Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10550679	GEIGER ET AL.	
Examiner	Art Unit	
Faulk, Devona E	2615	

SEARCHED					
Class	Subclass	Date	Examiner		
381	56,57,59	3/27/2007	DEF		
381	56-59,1,17,19,300,307,309,310	11/15,20/2007	DEF		
381	60,26,74	11/21,26/2007	DEF		
702	108-112	11/26/2007	DEF		

SEARCH NOTES				
Search Notes	Date	Examiner		
Assignee/Inventor Search	3/27/2007	DEF		
word search/combined class/word search	11/15,20/2007	DEF		
Consulted with Ping Lee, suggested additional searcin in 381/60 and to check with Huyen Le	11/21/2007	DEF		
Consulted with Huyen Le, said no searches in their area of 381	11/21/2007	DEF		
Cosulted with Xu Mei, suggested additional searches in 381/26 and 74	11/21/2007	DEF		
Consulted with Walter Briney, suggested additional search in 702/108-112	11/21/2007	DEF		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	

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